Wyeast Technology 354A FET Cycling Control

User Manual

1. Introduction

Power cycle testing is an important measure of long term reliability. Power cycling repetitively stresses parts by thermal heating and cooling, straining solder connections and other package features. In many cases a certain temperature swing is given, such as Tj swing of 100°C. It is not an easy task to control and measure junction temperature swing with general purpose test instrumentation. Even if the part is characterized correctly before testing, testing itself changes thermal parameters, and devices must be re-characterized often during a test.

2. Basic Features of the 354A

The 354A is designed to outperform current, in-house designed cycling systems by addressing the problems of interface change and initial performance differences noted above.

The key feature of the 354A is the combination of a cycling controller and thermal characteristic measuring instrument. After some initial measurements on the parts under test, the instrument is able to accurately read and record every devices junction temperature before and after *each and every power cycle*. This provides a running record of thermal interface performance, the primary figure of merit affected by power cycle testing. Even better, the system is able to dynamically adjust power levels for each device to maintain a controlled temperature swing. This power level adjustment is done individually for every device, and with no manual interaction required.



354A Front Panel View, With Heat Supply

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2.1 Overall Function of the 354A

The **354A** attaches to all leads of FET devices under test. (DUTs) It takes power from an external DC supply (Heat Supply,) and routes it to the correct device according to timing and test parameters. Voltage is controlled by the Heat Supply. The **354A** controls current by active control of DUT gates. A host computer connects to the **354A** to provide user interface, data collection, and dynamic adjustment of cycling conditions. All physical timing parameters are controlled by the **354A**. This eliminates fine timing dependency on the host computer's operating system, and allows very low jitter cycle timing and measurement triggering.



2.2 K- Factor Measurement

With the host computer, and an appropriate thermometer system, the **354A** may be used to measure device K factors. The K factor is a number that relates body Diode Forward Voltage Drop (Vd) to temperature at a given current. K factor is needed by the system to enable measurement of DUT junction temperature, in actual cycling and thermal characterization. Offset is also measured, enabling absolute temperature measurements to be taken. K factor and offset are recorded by DUT serial number, prompted from the user. The system is then able to correlate a measured diode drop Vd with a absolute junction temperature (Tj) to be used in further testing and data collection.

The graphical host software provides a routine for the user to make K factor measurements, which must be done before cycling or measuring of a part starts.

2.3 Thermal Characterization

The **354A** is capable of making thermal characterizations on a part, including effective Thermal Resistance to Sink ($R_{j-s \text{ effective}}$) needed for controlled cycling, as well as Junction to Case Thermal Resistance (R_{j-c}) which needed for a good data sheet specification. The units of both these characteristics is °C temperature rise per Watt of power, °C/W.

Effective Thermal Resistance to Sink is a measurement of junction heat rise mounted on a given heat sink, at a given power level, over a given amount of time.

in example:

A certain TO-247 part is mounted to a 20°C water cooled plate. The junction temperature is equalized to 20°C. A power pulse of 200 Watts is applied for 5 seconds, and the junction temperature is measured immediately after removal of power at 118 °C. R_{j-s} effective is then (118 °C-20°C)/200W, or 0.49°C/W. This value may then be used in future cycling to help determine the required power level for a given temperature rise.

The **354A** measures Vd on every device in testing, before and after every power cycle. The host computer uses recorded *K factor* and *offset* to obtain junction temperatures before and after the power cycle occurred. If the temperature difference, (temperature swing) is too low, power level is increased in subsequent cycles. If the swing is too high, power level is decreased. The host computer records details of every cycle, including power level and temperature swing, actually recording $R_{j-s \text{ effective}}$ in testing for every DUT, for every cycle.

Internally, the **354A** contains a precision current source, presently fixed at 10mA. This current source is used for every *Vd* measurement. Ibe fixed to 10mA.

All measurements are taken with the same test current, including *K factor*, *offset* and in-test temperature measurements.

2.4 Power Cycling

The **354A** automatically controls power cycling. Before cycling, the graphical host software host machine will allow the user to enter certain parameters, including:

1. Cycle quantity	The number of cycles to run
2. Target swing ($^{\circ}C$)	Desired temp swing. Usually 100°C
3. Max Current (Amps)	The maximum current allowed for heating.
4. Thmax $(^{\circ}C)$	Maximum final junction temperature.
5. $Tlmax$ (°C)	Maximum starting junction temperature.

The host computer will then control the 354A to produce cycling of the given temperature excursion in the given cycle time. If the 354A is not able to heat the part through the requested swing within the maximum current limit, testing will terminate with an error. *Thmax and Tlmax* are protection limits to terminate cycling if a DUT becomes overheated, say, in the case of a fan or cooling system failure.

During power cycling, the host computer will record the cycle count, the before and after temperature for each DUT, current and voltage applied to the part, and a time stamp. This information is stored in a mysql database, for easy and fast access by the host software.

3. 354A Connections

3.1 Front Panel Connections

3.1.1 DUT interface cables

The main connections on the front panel of the 354A are for the DUT interface cables. All connection to the DUTs are made by over this single connector. The connection is described in detail in the below with the 281-001-01 DUT cable assembly in Section 4. 354A Accessories.

3.1.2 Current and Voltage auxiliary output connections

Two BNC style Connections are provided on the controller unit, on the lower right hand side of the display panel. These provide analog signals corresponding to the instantaneous heat current and voltage at the DUT. They are referenced to the digital ground of the system, or HTP. The current signal is calibrated to 0.1V/A (measured heat current) and the voltage output is 0.05V/V (measured heat current.) These may be monitored with an oscilloscope or voltmeter. Be aware that these quantities may jump through undefined values while the machine is switching between DUTs.

3.2 Back Panel Connections

A labeled photograph shows the connections on the back panel.



354A Back Panel Connections

The 354A takes power from a "Heat Supply" on the Power terminal blocks. Observe polarity, positive is on the right, negative on the left.

Power Supply Control provides an emergency stop function. It carries a normally closed signal from the E-stop switch to the Heat Supply. Circuitry in the Heat Supply

connector end disables the supply if the E-stop switch is pushed (opened).

AUX 5V OUT is provided to run accessories requiring 5V power. This output is capable of 3 amps, but is not fused or protected in any way. Do not short this out, it will probably cause no harm, but will cause the cycler to lose power.

RS232 Serial connects to a 9 pin female D-sub connector on the back panel. This provides communications from the 354A to the host computer. Note that this connection ties Earth ground between the host computer and the 354A. It would be advisable to run the computer and the 354A from the same AC line circuit, to avoid ground loop problems.

AC Line is brought in on a standard IEC line entry. The 354A uses auto ranging supplies internally, enabling the use of any AC voltage from 110 to 240VAC. Note that accompanying the Beta Unit (#101,) the Heat supply and the Host Computer are configured to take 230VAC, so it would be convenient to use the same for the 354A. Remember, it is very advisable to have the 354A and the host computer plugged into the same AC line circuit.

4. 354A Accessories

4.1 281-001-01 DUT Cable Assembly

The 281-001-01 DUT Cable Assembly is documented on an accompanying drawing, which shows the cable, flying leads and connector.

The 354A provides true Kelvin connections to all leads of a power FET DUT. For each connection, Gate, Source and Drain, there are two connecting wires *Force*, and *Sense*. Drive current flows through the *Force* line, and voltage is sensed off of the *Sense* line in every case, eliminating voltage drop errors from cable and switching connections. This enables very accurate low voltage measurements to be made.

Each DUT interface module card provides a front panel connector for interfacing with a DUT. This connector is a D-sub type 7W2 shell, with two power pins and 5 signal pins. Power pins are used for Heat Supply high current *Force* to Source (negative) and Drain (positive) 4 signal level pins are used, two for Drain and Source *Sense* lines, one for Gate *force*, and one for Gate *sense*.

The 281-001-01 Cable assembly is made up for conveniently connecting a MOSFET DUT to the 354A cycler. It provides a male connector for one end, plugging int to the module interface card, and flying wire leads for the other, which may be soldered or bolted onto the DUT end. These are bundled together in expandable polyester braid.

Wire colors are:

Signal	Wire
Drain Force	AWG 12 (large) Black

Signal	Wire
Source Force	AWG 12 (large) White
Drain Sense	AWG 22 (small) Red
Source Sense	AWG22 (small) Blue
Gate Force	AWG22 (small) Yellow
Gate Sense	AWG22 (small) Violet

Note that in operation, *Force* and *Sense* wires are connected <u>at the DUT</u>. Ensure that this wiring is correct before starting testing, as misconnections may cause damage to a interface module card or DUT.

4.2 910-027-01 H-Bridge Balance Adapter Board

These boards are documented in schematic 910-027-01. This description will be more clear if the schematic is on hand.

The 354A Cycle Controller has been designed to power cycle single MOS transistor devices. An H bridge is four MOSFETS, arranged of two in series to form one leg, and two in series to form the other. The purpose of the 910-027 adapter boards is to make an H-bridge appear like a single transistor to the 354A. This is done by equalizing the current through both legs, and making the center point of each leg approximately one half the total voltage. With ¹/₂ current and ¹/₂ voltage on each MOSFET, each one takes ¹/₄ the full heat power.

Voltage balancing is done using a single reference generator and two OP Amps. R6 and R7 form the reference generator, splitting the input voltage by

$$Vout = \frac{Vin * R7}{(R7 + R6)}$$

16.5k/(16.5k+75k) or approximately Vin*0.18.

Amplifiers U17 G1 and G2 control the center point voltage on H bridge outputs OUT1 and OUT2, respectively. Feedback is divided down by resistors R9 (24.3k,) R8 (43.2k) on OUT1, giving dividing ratio of approximately 0.36. The op amp acts to equalize its input voltages, thus it controls the voltage at OUT1 to be approximately ½ the input voltage, to provide equal voltages on pins 3 and 2 after the voltage dividers. Transistor Q1 acts as a high voltage amplifier to extend the range of U17. Not shown on the schematic as drawn is a feedback cap, from Q1-C to pin 3 of 1000pF, this is needed for stability.

The voltage on center point OUT2 is controlled in the same manners, by op amp U17 G2, pins 5,6,7.

U17 requires an isolated source of 15V to function, this is provided by the DY910-028-01 isolating supply. The supply takes 5V in and outputs 8 completely isolated

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15V sources, which actually range from 22V open circuit to around 16V when loaded.

910-028-01 isolating supply may take 5V from an auxiliary connector on the back of the 354A unit, (serial #101.) See the <u>Back Panel Connection</u> Drawing for location.

4.2.2 Cable Connection to the 910-027 boards

The 910-027-01 boards have already been connected to DUT interface cables. The connection uses a single 2 position terminal block,

4.2.3 Checking the 910-027 boards

The 910-027 boards are required for cycling H-bridges. They may be checked simply by measuring voltage from OUT1 and OUT2 to ground, these should be approximately ½ the total voltage on the part. This voltage may be adjusted by trimming resistor R6, however, this is not an easy task.

4.3 281-003-01, Debug Switch Assembly

The 281-003-01 Debug switch assembly is used for re-programming the internal software of the 354A controller unit. It consists of a toggle switch and pushbutton switch, wired to a small 5 pin pocket header, described as followed.

281-003-01 Debug cable for 354A cycler. Currently, this is a free hanging cable to bring out the controller RESET and PSEN signals. These are used with a switch and pushbutton to reprogram the controller.

A shrouded header is heat shrunk to the cable... which is cat 5 4 pair wire

pin 1 /PSEN	blue of blue/white
pin 2 DGND	white of blue/white
pin 4 DGND pin 5 RESET	white of orange/white orange of orange white.

The toggle switch is wired to the /PSEN signal, the pushbutton is wired to the RESET.

See directions below in Section 5 for flashing the Controller Software.

5. "Flashing" the 354A Controller Software

5.1 Controller Code

The 354A controller uses a microcontroller to provide all control and communication. This microcontroller is flash programmable over the same serial port used for normal host/controller communications. Wyeast Technology may send software upgrades with instructions to "flash" the new version into the controller. The controller should

not be flashed w/o specific instructions and an upgrade file.

5.2 Cautionary statement

The 354A must not be connected to an energized heat supply while flashing the code. Connection to heat power could damage the 354A, as it is not in operational mode when being programmed. The supply should be disabled, or ideally, off, before proceeding with flash upgrades.

5.3 Upgrade file name

The name of the upgrade file to be programmed into the controller is always cycle.hex. Wyeast Technology will place this file into the proper directory. The customer should check to be sure the date of this file is as expected.

5.4 Flashing procedure.

- a. stop any running tests and ensure that the heat supply is off.
- *b*. exit the host control software.
- *c*. attach the 281-003-01 debug cable assembly to the debug connector, just under the AUX 5V out connector on the back panel, and free hanging. This connector may be left inside the 354A unit, if so, unplug the AC line power before removing the chassis cover to extract it. *Never* trust a single pole switch to truly disconnect AC line power.
- *d.* double check the heat supply is off. Flick the toggle switch to "P", then reset the controller with the pushbutton. It is now in "programming" mode.
- *e*. send the upgrade code to the controller by running the program "aprog" from a command line shell in /home/tester.
- *f*. flick the toggle switch back away from "P" and reset the controller again using the pushbutton. The 354A is now back in normal run mode.
- g. remove the debug cable assembly and store in a safe place.
- *h.* re-start the host GUI software, in its startup text window, it should report the new software version. This should be verified against the information sent by Wyeast Technology along with the upgrade file.

6. CycWin 354A Host Software

6.1 Software Introduction

Software running on an attached Host Computer handles all control and data logging features of the 354A. This software runs and monitors the 354A FET Cycle Controller and logs all data into a flexible database for reporting and analysis. It uses a Graphical User Interface (GUI) for ease of use and clarity.

6.2 Logging in and Starting the Software

Login to the host computer ("*checker*") with the user name "*tester*." The password for user *tester* as delivered is "*test354*" Start the Host Software GUI either with the desktop shortcut "*CycWin 354A Host Software*," or from terminal shell by clicking on the "*Terminal Shell*" and running the script "*CycWin*" from the shell prompt. If run from a Shell, useful debugging information will appear in the text terminal along with the GUI.

The CycWin Host Software starts with a main window:

🗙 354A host controller	
System Help	
Test Control Reports A	dmin Panel
Parts etc create/edit parts measure k-factor	Tests etc create/edit project start new test stop managed test
statu	s: 0x80 POI

CycWin Software Main Panel

From this window, the user may chose to enter part information, stop or start a test.

6.3 Create and Edit Parts

Part information must be entered before starting a test.

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To do this, click on the :
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button.

This will open another screen, the *create/edit parts* Window:

create/edit parts

	Re	gistered parts	found in datal	base	
name	number	description	created	K-factor	K-offset
irf720	samp1	first test DUT	Thu May 08	-2.0945mV	0.6542V
irf720	samp2	samp2	Thu May 08		
irf720	samp3	samp3	Thu May 08		
irf720	samp4	samp4	Thu May 08		
irf720	samp5	samp5	Thu May 08		
irf720	sampб	sampб	Thu May 08		
irf720	samp7	samp7	Thu May 08		
irf720	samp8	samp8	Thu May 08		
	ne	w delete	close win	dow	

Create/Edit Parts Window

To create a new part, click the

new

button, which will open up a

screen allowing the user to enter new parts:

The Part Name field ought to be filled in with serial number, the part number should be the lot code and part type. A short description must also be entered.

If the K-factor information is known it may be entered. If Kfactor data is not known, the

🗙 define a new part to be tested 🦳 💶 🗙				
Part name:				
part number:				
description:				
K-factor (if known):				
K-offset (if known):				
Cancel OK				

New Part Definition Window

software provides a routine for the user to determine it, using the 354A. K factor data must be known before testing of a part. This is the only way the machine can determine the before and after temperatures.

If an error is made in part data entry, highlight the corresponding row in the Create/Edit Parts window by clicking over it. Then use the "delete" button to remove the row.

6.4 Determining K-Factor

After creating the parts in the prev	vious screen, a routir	ne may be run to determine K
factor. This is selected by the	measure k-factor	button from the main
startup window.		

A K-factor instruction window will appear:

X K-factor measuremen	t window 🎅) 🕞 🗆 😜
K-factor measurement hap selected will be hooked up stabilize the parts at one te Vd, then repeat for a coupl rewritten for clarity (RJM)	pens as follov to the tester mperature ar e more tempo	ws: the parts you have and placed in an oven; nd the tester will measure eratures. This text will be
Hook the following parts Tag 1: attach part 'irf720	up to the te samp2 <i>(</i> sar	ester exactly as specified: mp2)'
Cancel	<- Prev	Next ->

K-Factor Instruction Window

It is critical to hook up the parts exactly as described. When the instructions say "*Tag*," here, they mean DUT channel. Thus, "*Tag 1*" refers to DUT channel 1, "*Tag 2*" refers to channel 2.

Read the instructions, check the parts are hooked up to the correct DUT channel card, and press the "*Next->*" button. The K factor taking window will then show up:

X K-factor meas	urement window	<u>ج مع کی (8</u>
Perform measurem and stabilize at app enter the exact tem tester will reject the 'kfm_stability' in the wording, also work	ents at 3 different proximately 25, 60 perate and click 'n e measurement if V e config file). TODO on better layout.	temperatures place DUTs in oven , and 95 degrees C; for each case neasure' to record K-factor data. The d isn't stable enough (NOTE: see : translate into more user-friendly
enter exact temp:	25.6	measure @ approx. 25C
enter exact temp:		measure @ approx. 60C
enter exact temp:		measure @ approx. 95C
	Cancel	<- Prev

It is critical that all parts selected be at the same temperature... this may be accomplished by attaching them all to the same "isothermal block," a large block of copper that maintains the same temperature across its entire volume.

A thermocouple should be placed directly on the mounting tab of the device measured. It is important to get the temperature of the semiconductor die, as accurately and as stable as possible when making K factor measurements. The 354A can be no more accurate than the K factor measured.

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Heat the DUTs together in an oven or a carefully controlled d hotplate. Ensure than however they are heated, you are able to take a stable measurement at close to the requested temperatures.

When the part is stabilized at approximately 25° C, enter the <u>exact temperature</u> <u>measured</u> in the fill in box on the left, and click the "*measure at approximately* 25° C" button. This will probably be room temperature.. just ensure that that the parts are well stabilized (not warming or cooling.) and that the measurement typed into the window is the actual temperature when the button is pressed.

Heat the part and stabilize at approximately 60° C. Again enter the <u>measured</u> temperature and click the "*measure at approximately* 60° C" button. It is not critical what the exact temperature is, so long as it is measured accurately and entered correctly.

Repeat for the 95°C measurement. The software will then run a linear regression to determine K-factor and offset for the part. The information from the k-factor determination procedure is saved in the system database.

Devices of identical size from the same wafer lot generally have very close to the same K factor. You may decide to take K-factor on a sample of parts only, and copy in data part to part using the "K factor (if known)" option in the *New Part Definition Window*.

6.5 Starting a Test

Once part numbers have been entered, and K-factors have either been measured or entered, a test may be started. Select the start new test from the main from the main

A panel will appear asking the operator to select parts to test. Selected parts are highlighted by clicking with the mouse, and using *ctrl*-click or *shift*-click to add to the selection. Ensure the correct parts are selected, and hooked up exactly as instructed in the window appearing next. All data logging is dependent on the fact that the correct devices are hooked up to the correct DUT channels.

Highlight parts with mouse to select.	X Start a New Test
	8 8 (8)
	99 (anotherpart)
	irf3711_1 3711_1 (to220 properl)
	irfp3415_1 1 (freds transis)
	50M75LFLLX3 3 (test part, TO)
	50M85JVRP_1 1 (\$0T227 part)
	Cancel Next ->

Select Parts for Test Window

The software will allow the user to chose which part gets connected to which DUT interface. Just click in the Position Number field to change this number. You must select a different position for each DUT.

X Start a New Test
For the parts you have selected to test, choose a Tag number to which you will now
hook up the part. When all of the parts are hooked up to the tester exactly as
specified, press "next".
Position 1 💌 attach part 'irf3711_1 3711_1 (to220 properl)'
Position 2 💌 attach part 'irfp3415_1 1 (freds transis)'
Position 3 💌 attach part '50M75LFLLX3 3 (test part, TO)'
Position 4 💌 attach part '50M85JVRP_1 1 (\$0T227 part)'
Cancel <- Prev Next ->

Select Position for Test Window

Be sure to hook up the parts exactly as listed in this screen.

Next, fill in the	X Start a New Test		×)
information requested	Please complete the following:		
by the Test Limits	select project for test:	default project 🔹 🔻	
Entry window. Full	test name:	new_test	
temperature refers to	description	test of norts	
the temperature swing	uescription.		
the test will shoot for.	# of cycles:	10000	
Default temperature	full temperature swing:	100.0	
swing is 100C, default	maximum start temperature for a part:	50.0	
number of cycles is		<u></u>	
10,000 but this may			
be changed by the			
user.	Cancel <- Prev Next ->		

Test Limits Entry Window

Saved reports will be grouped into subdirectories by project. To change the project, use the pull down selection in the "select project for test" box. Projects must have already been created using the create/edit projects button on the main panel.

X Start a New T	est	(×)
Confirm and hit '	START:	
	* project: default project	
	* test name: new_test	
	* description: test of parts	
	* test will run for 10000 cycles before terminating	
	* parts will be cycled in a 100.0 degree swing.	
	* start-temp will not be allowed to exceed 50.0	
	degrees.	
	* these parts will be used:	
	tag#3: 50M75LFLLX3 3 (test part, TO)	
	tag#2: irfp3415_1 1 (freds transis)	
	tag#4: 50M85JVRP_1 1 (S0T227 part)	
	tag#1: irf3711_1 3711_1 (to220 properl)	
Cancel <-	- Prev Start test now	

Start Test Confirmation Window

Finally, a window will appear asking the user to confirm the limits and part hook up order, then to start the test. If anything is wrong, correct by using the "<-*Prev*" button or Cancel. The user should carefully double check wiring and test limits before starting the test.

6.6 Test Action

Parts will be cycled in order. As heating current is applied to a part, the green "*Channel*" indicator LED is lit up on the corresponding module card. These should stay lit for 4 seconds before the next unit is energized.

The test will presently start at zero heat current commanded, and slowly ramp up until the target swing has been reached. The user should monitor the test until it has reasonably stabilized, and ensure cooling is properly functioning.

The host software queries the 354a on every cycle, calculating temperature swing. If the swing is to high, it reduces heat current command. If the swing is too low, the heat current command is increased. It will take several tens of cycles before the temperature swing is truly stabilized... this may be improved for faster convergence in the future.

Data is logged to an SQL database residing on the host machine. One report function is currently implemented in the host control software. To access this report generator, select the "Reports" tab from the top of the 354A host control window, then chose the desired project and test name. A message will then appear with the location of the file created:

X 354A host controller	×
System Help	
System Control Reports	Admin Panel
test report	s
Select a project:	default project 🔻
Select a test:	firsttest 🔻
	antional: 500
test firstlest nas U cycles)	
0	enerate report
9	

You may select the number of rows to go into the comma delimited file.

For example, if there are 5000 cycles taken, and the user asks for 500 rows, the software will select every 10^{th} row to export.



This report file contains comma delimited data tabulated for each DUT, organized in separate columns for each part, making it convenient for comparisons between devices under test.

6.7 Rtj-c/Rtj-s Testing

The 354A may be used for Rtj-c and Rtj-s measurements on characterized FETs. Rtj-c and Rtj-s measurements require measurements of junction temperature, device case temperature, and sink temperature.

Thermal resistance measurements are important for datasheet characterizations. Designers use Rtj-c and Rtj-s numbers to design cooling systems that provide adaquate cooling to a semiconductor in an application.

6.7.1 Definition of thermal resistance

Thermal resistance can be loosely defined as the opposition of a region to heat flow. An analogy to electrical circuits can be drawn, with temperature differences substituted for voltage, and heat flow (power) substituted for current:

$$Rt = \frac{(TI - T2)}{Power}$$
 in units of °C/W

T1 - T2 is the temperature differnce across the region in interest. In our case, for junction-to-case thermal resistance:

$$Rtjc = \frac{(Tj - Tc)}{Power} \qquad ^{\circ}C/W$$

and for junction-to-sink thermal resistance:

$$Rtjc = \frac{(Tj - Tsink)}{Power}$$
°C/W

Junction temperature of a part is measured in the same manner as the 354A uses to track temperature swing during cycle testing, by voltage drop at a given test current over the DUT's integral body diode.

6.7.2 Use of Heat Block

Case and sink temperature may be measured using a special copper "heat block" which provides thermocouples measuring the block's own "sink temperature" and the temperature of the mounted DUT directly below the semiconductor die. Case, sink and junction temperature should be measured simultaneously. In practice, measuring maximum temperature on the case and sink, and taking a thermal measurement immediately after a heat pulse gives good results.



In the picture above, the Tc case thermocouple can be seen protruding a small amount over the surface of the copper heat block. This thermocouple is isolated from the copper by a small insulator fit into the hole. The case thermocouple must protrude enough to put gentle pressure on the metal of the DUT case.

Water is used as a thermally conductive media in Rtj-c testing. Water pulls itself between the part and the block by capilary action, greatly improving thermal contact. Thermally conductive grease would work, but be very messy to clean up and deal with.

It is important to correctly position the DUT over the case reading thermocouple. The thermocouple must touch the case directly under the semiconductor die mounted in the package.

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The DUT should be securely clamped down to the heat block during Rtj-c testing for repeatable results. Good physical mounting is very important to get accurate values in this test. The heat block should be secured to a cooling plate with water running.

6.7.3 Host Software Operation for Rtj-c testing

Host software provided with the 354A supplies an Rtj-c measuring routine. Select



from the main System Control panel. This will open the Rtj-c measuring screen:

select tag# for the part to measure:	1 -	Measurements
select a part: test3 3 (dut3)	-	Enter case temperature (celcius):
Approx. heat current (amps):	8	Enter sink temperature (celcius):
set pulse duration (sec):	12	
	-	heat power= 0.0 W
step 1: heat part		Tj= 0.0 °C
step 2: calculate]	calculated Rtj-c= */W
step 3: accept data		calculated Rtj-s= "/W
	cancel & clo	ise window

Just as in setting up cycle testing, it is critical that the correct, well charcaterized part is selected, and that it is on the correct DUT (tag) channel. Parts and position are selected by the pull down menus in the upper left of the panel.

Chose a heating current enough to bring the part up to good operating

temperature. This should probably be close to the test current the part runs in cycle testing, to give the part a swing of 100C.

Pulse duration is limited to 12 seconds at this point. There is no reason to use a shorter time than the default12 seconds, and it may impact accuracy to do so.

Set a thermocouple thermometer to measure maximum temperature on both Tc and Ts thermocouples, in °C. The maximum temperature will occur right before pulse termination, which is when the junction temperature is measured by the 354A.

Click the

step 1: heat part

button to start the heat pulse. The 354A will then time and control a pulse, with current slightly under the "Approx. heat current" requested on the panel.

When the pulse has terminated, read the maximum temperatures from the thermometer and fill them in the boxes provided on the right side of the panel:



Then click the Rtj-s values.

step 2: calculate

button to calculate Rtj-c and

These may be added to the database by clicking

step 3: accept data

The host software will prompt for some descriptive text to add as a comment to that specific test instance. The measurement will be added to

X store Rt measurement	□ × □
About to store measureme Please provide a descriptio	ent data into database. on and press OK.
description: Type a descri	ption here.
Cancel OK	

the table rt_measurements when "OK" is clicked.

7. Calibration Procedure

The 354A is calibrated at the factory, and user calibration is ordinarily not recommended. Mistakes in calibration may lead to incorrect data, and improper calibration procedure could possibly damage the Beta unit 354A.

7.1 Calibration Concepts

The 354A makes three critical measurements:

- Diode Forward Voltage (Vd,) which corresponds to DUT temperature.
- Heat Voltage (*Vheat*)
- Heat Current (*Iheat*)

These measurements are made by the central controller, using the same analog hardware and analog to digital conversion for each DUT. This results in only one calibration being valid for all DUTs; it is convenient to do this with DUT #8, especially in calibrating Diode Forward Voltage.

The hardware is assumed to be linear. Two calibration numbers are supplied for each measurement, *offset*, and *scale*. The host records data as:

```
measurement = (raw)(scale) + offset
```

where *raw* is the data directly from an analog to digital conversion, *scale* and *offset* are numbers to convert this into a engineering unit quantity.

These calibration numbers are determined by taking data under two different test conditions.

Calibration numbers are stored in the file 354a.conf. If needed, this file is edited to insert new calibration numbers.

A spreadsheet is available to do the calculations for calibration. Without this, the these calculations would be tedious and very error prone. The raw ADC (unscaled) data is not accessible to the user, and must be back-calibrated from reported values and current calibration numbers in use.

7.2 Calibration Equipment

Suggested calibration equipment should be on hand before starting calibration:

- 1. text editor on host computer
- 2. Spreadsheet calibration_worksheet.sxc
- 3. Calibrated voltage meter with clip leads (34401A is ideal)
- 4. Calibrated current meter capable of 10 amps, with heavy clip leads

- 5. Extra DUT cable or male connector
- 6. Schottky Diode and small clip leads
- 7. Ordinary MOSFET DUT
- 8. Current limiting heat supply

7.3 Vd Calibration Procedure

Vd will be calibrated by measuring at two separate points. It is convenient to have a Schottky diode to simulate a DUT at high temperature. This will eliminate the need to stabilized the DUT at two different temperatures.

a Onen the 254e Heat	🗙 354A host controller 🎱 🗧 🗆 🗙
a. Open the 354a Host Control software and switch	System Help
	Test Control Reports Admin Panel
to the Admin Panel using the top tabs.	can tweak layout later send start test send stop test read DACs force measurement read cycle data
	status: 0x80 POI

a. Open spreadsheet calibration_worksheet.sxc, using OpenOffice

b. Open file 354a.conf in a text editor such as vi or kwrite.

# calibration data	
calibration.Vd_offset=	0.00872252
calibration.Vd_scale =	0.00040683
calibration.Vh_offset=	0.38718928
calibration.Vh_scale =	0.01531827
calibration.Ih_offset=	0.11073388
calibration.Ih_scale =	0.00644809

c. Copy the <u>existing</u> calibration numbers *calibration.Vd_offset* and *calibration.Vd_scale* into the spreadsheet cells labeled *Vd_offset* and *Vd_scale*, cells B6 and B7. Locations for user input are denoted by a <u>blue background</u>.

	A	В	С	D	E	F	G
1			354a Hand	Calibration	Worksheet		
2							
3	VdDiccle Forwar	dDrcp Calibrati	an				
4							
5	Existing Cal (from 3	54a.conf)					
6	Vd_affset:	0.00872252					
7	Vtl_scale:	0.00040683					
8							
9	Sample	Actual Voltage readfrom meter	DUT8 meas_1 from 'force meas	DUT8 meas_2 'from 'force meas	DUT8_meas3 'from 'force meas'	DUT8 avg (calculated)	raw from ADC (calculated)
10	Schattky Diode	0.27062000	0.27070000	0.27070000	0.27150000	0.27096667	644.60375751
11	Normal DUT	0.58621000	0.58720000	0.5860000	0.58640000	0.58653333	1420.27582364
12							l I
13	New Calibration						
14	NEW Vd offset	0.00835646					
15	NEW Vd scale:	0.00040686					

Calibration Worksheet, Vd section

d. Attach the voltmeter leads to DUT#8, Source and Drain leads. If the meter is properly calibrated, it is not necessary to orient these leads to always read positive voltage.. just enter positive voltages only in the Calibration Worksheet.

e. Clip the Schottky diode in parallel with DUT#8. The diode's cathode is connected to DUT8's Drain lead, the diode's anode is connected to DUT8's Source lead. In this way, the diode is effectively in parallel with the internal body diode of DUT8.

f. From the *Admin Panel*, click the *force measurement* button. Measurements will appear in the shell window. Immediately read



Schottky Diode in Parallel with DUT, with voltmeter leads attached

the attached voltmeter for the actual diode voltage. A hold function is usefull here.

Copy the voltmeter reading into cell B10. It should be much lower than an ordinary diode drop.

Copy the last DUT8 measurements from the shell window into the spreadsheet cells C, D, and E10. In the picture here, these are 0.2744, 0.2744, 0.2744..

Shell - 354A Test	
Session Edit View S	Settings Help
DUT 2 measurement:	[0.5763, 0.5763, 0.5763]
DUT 3 measurement:	[0.5730, 0.5734, 0.5730]
DUT 4 measurement:	[0.5758, 0.5758, 0.5758]
DUT 5 measurement:	[0.5730, 0.5730, 0.5730]
DUT 6 measurement:	[0.5795, 0.5803, 0.5795]
DUT 7 measurement:	[0.5893, 0.5889, 0.5889]
DUT 8 measurement:	[0.2748, 0.2752, 0.2744]
DUT 1 measurement:	[1.6747, 1.6747, 1.6747]
DUT 2 measurement:	[0.5763, 0.5763, 0.5763]
DUT 3 measurement:	[0.5734, 0.5730, 0.5726]
DUT 4 measurement:	[0.5763, 0.5763, 0.5763]
DUT 5 measurement:	[0.5730, 0.5730, 0.5730]
DUT 6 measurement:	[0.5803, 0.5807, 0.5803]
DUT 7 measurement:	[0.5893, 0.5893, 0.5889]
DUT 8 measurement:	[0.2744, 0.2744, 0.2744]

Shell output from "force data"

g. Remove the paralleled Schottky and repeat the process to get a sample of ordinary room temperature DUT diode drop. Insert these values into row 11 in the spreadsheet.

h. The new calibration values are in cells B14 and B15. Edit the 354a.conf file (values *calibration.Vd_offset*, and *calibration.Vd_scale* to update these.

7.4 Vheat Calibration Procedure

Vheat will be calibrated in the same way, by measuring at two separate points. To get the two points, an adjustable Heat Supply must be connected to the 354a. This procedure will use the "pulse device" function to apply voltage, but not current to the DUT.

It is convenient to remain with DUT#8. Leave the voltmeter attached, but be sure to check the Schottky diode is removed.

a. Open file 354a.conf in a text editor such as vi or kwrite.

		A	В	С	D	
h Copy the existing	22					
calibration numbers	23	Existing Cal (from 3	54a.conf)			
	24	Vh_affset:	0.38718928			
<i>calibration</i> . Vh_offset and	25	Vh_scale:	0.01531827			
<i>calibration.Vh_scale</i> into the	26					
spreadsheet cells labeled	27	Samnle	Actual Voltage readfrom meter	DUT8 V heat from cvole data	raw from ADC (calculated)	
<i>Vh_offset</i> and <i>Vh_scale</i> , cells	28	Vheat1	8.15350000	8 15360000	507.00312242	
B24 and B25. Locations for	29	Vheat2	48.15000000	48.17590000	3185.00135590	
user input are denoted by a	30					
blue background.	31	New Calibration				
	32	NEW Vh_offset	0.39197378			
	33	NEW Vh_scale:	0.01530864			
	34					

Calibration Worksheet, Vh Section

c. In the Admin Panel, right hand side, chose "select D.U.T. #8". Enter the value 0 (zero) into the white DAC setting box, and click the button *write DAC*. The shell window should respond "wrote 0x0 to D.U.T. 8 (response=0x0). This will set the current command to 0, where it will not cause the applied voltage to drift while the calibration shot is in process.

b. Adjust the heat supply for an output voltage of approximately 8V.

c. Observe the voltmeter, and click the *pulse device* button. Read the value on the voltmeter when the voltage is stabilized. Ideally, the meter should be read two seconds after the pulse goes into effect (green channel light on DUT module,) but the results will be fine as long as the heat supply is stable. Record the voltmeter reading

(actual heat voltage) into spreadsheet cell B28.

d. Click the "*read cycle data*" button on the left bottom of the *Admin Panel*. Cycle data will scroll into the shell window. Read the reported V_heat measurement for DUT 8.

.5502, 0.5502], Vd_after=[0.3537, 0.3533, 0.3533] DUT 7 cycle data: cycle# 221, V_heat=7.2804, I_heat=8.7125, Vd_before=[0.5685, 0 .5685, 0.5685], Vd_after=[0.3708, 0.3712, 0.3712] DUT 8 cycle data: cycle# 222, V_heat=8.0923, I_heat=0.1107, Vd_before=[0.5860, 0 .5860, 0.5856], Vd_after=[0.5860, 0.5856, 0.5860]

Cycle Data Scrolled Into Shell Window

For example, the value read here is $V_heat=8.0923$. 8.0923 would be entered into spreadsheet cell C28.

e. Repeat this process at a higher heat voltage (ideally a little over the actual DUT heating voltage used for testing) to get information for spreadsheet row 29, the vheat2 calibration sample.

f. The new calibration values are in cells B32 and B33. Edit the 354a.conf file (values *calibration.Vh_offset*, and *calibration.Vh_scale* to update these.

7.5 Iheat Calibration Procedure

The Iheat calibration is done almost exactly like the Vheat calibration. It uses the current limit of the power supply to provide two separate test currents, instead of test voltages.

a. Copy the <u>existing</u> calibration numbers *calibration.Ih_offset* and *calibration.Ih_scale* into the spreadsheet cells labeled *Ih_offset* and *Ih_scale*, cells B43 and B44.

b. T<u>urn the heat voltage supply down to about 4 volts</u>, and set the current limit for approximately 3A. It is very important to have the voltage backed down to a low level or the output capacitance of the supply may deliver a damaging spike into the interface module cards.

c. Remove DUT 8, and attach a current meter. Current should flow FROM DRAIN FORCE into the + of the meter, out the – and back into the SOURCE FORCE. A spare DUT cable is handy for this, simply connect the meter to the large white and black heat current force leads. In the picture to the right, a meter is attached to an open male connector plugged into the interface module. It is not necessary to connect any other leads to the interface module card.



Current Meter Attached to Drain Force and Source Force

d. Observe the meter and click the *pulse device* button. Read the current meter when the heat current has stabilized, and record it in spreadsheet cell B47, *Actual Current read from Meter* for Iheat calibration shot # 1.

e. Click the *read cycle data* button and read the I_heat measurement for DUT #8. Enter this in spreadsheet cell C47.

f. Adjust the heat current limit up to a higher level (10 A works well,) **taking care not to exceed current ratings on the meter and test leads used.** Repeat steps c and d to fill in spreadsheet row 48, for calibration shot lheat 2.

g. The new calibration numbers are in cells B51 and B52, and should be updated into the 354a.conf file for calibration.Ih_offset and calibration.Ih_scale.

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8. Thermal Error Stackup

8.1 Thermal Error

Several factors influence the repeatability and accuracy of the 354a. What follows is a consideration of the most important errors affecting the Vd measurement, which is used to calculate both absolute temperature and temperature swing.

Assuming the machine has been calibrated, and all uncertainty comes from thermal drift properties of the differential amplifier, ADC and reference voltage and that the internal operating temperature of the 354A runs 25°C to 50°C (a 25°C delta)

Gain Errors:

reference error (on board controller uC) ± 100 ppm * 25°C = 1 ± 0.0025 (ref error)

gain setting resistor (100ppm/°C) on differential input amplifier: nom: 26.1k max : 26.1k * (1+.0001*25) = 26.165k min: 26.1*(1-.0001*25) = 26.034k

gain setting equation is 49.4k/Rset + 1, therefore gain is nominal: 2.89272 max: 2.89746 min: 2.88800

gain error due to gain setting resistor is approximately 1±.00163 (gain set err)

gain error due to amplifier is: 50 ppm/ °C , or $25*.00005 = 1 \pm 0.00125$ (gain err)

These gain errors total to a maximum of 1.00539, or $1\pm 0.539\%$ gain. With a 100 °C swing, the gain induced error could be as high as ± 0.539 °C.

DC accuracy value on the ADC is specified at 3 "LSBs" A LSB is nominally 2.5V/4096 counts, so this leads to an uncertainty of 0.00183V. The effect of this is reduced by the differential amplifier's nominal gain of 2.89272, for a diode voltage uncertainty contribution of 0.0006330. Given a "k" factor of 2.00mV/°C, this leads to a temperature uncertainty of \pm .0.317°C. With the above gain calculation, the measurement could be said to have error in the range of \pm 0.856°C, if all these factors stacked up in the worst possible combination.

Effects of thermally induced errors can be minimized by allowing the machine to warm up before calibration and use. It is also advisiable to measure DUT K-factors and offsets on the 354, rather than using other measurements, as this will eliminate absolute accuracy issues in the thermal measurement path.

9. Data Base Structure

9.1 354A System Data Storage Overview

During normal cycling operation, the Host Computer logs all measured heat quantities (voltage and current) and thermal measurements. The Host Computer calculates actual quantities from the raw data sent by the 354A cycler, using calibration values in the configureation file.

All data is written to a database, currently using MySQL residing on the host machine. The host software is also capable of writing to a network accessible Oracle database, if the tables are correctly set up.

9.2 Description of Tables

As shipped 2003-08-28, (unit 780102) the database name is dynalink_354a. Tables are:

table name	description
cycledata	all logged data for each cycle, each part
kfactor_measurements	K-factor measurement storage
parts	description of part, including calculated or entered K factor data
projects	project name and ID
tests	description of tests, including which DUT channel is connected to which part.

Tables of Database dynalink_354a

column name	description
fk_tests	the test ID number (keys to <i>tests</i> table.)
fk_parts	the part ID number (keys to parts table.)
cycle_num	cycle count number
T_before	temperature before heat pulse, in °C, calculated by Host from diode forward drop using K-factor and offset from parts data.
T_after	temperature after heat pulse
vd_before	forward diode drop before heat pulse (average of 3 from 354A)
vd_after	forward diode drop after heat pulse (average of 3 from 354A)
v_heat	heat voltage measured by 354A
i_heat	heat current measured by 354A

Columns of table cycledata

column name	description
fk_parts	the part ID number (keys to parts table.)
Vd	measured forward diode drop (average of 3 measurements sent by 354A)
temp	temperature that measurement was taken at
date_measured	the date and time the measurement was taken
notes	presently unused.

Columns of table kfactor_measurements

column name	description
ID	part ID number, ref'd by <i>fk_parts</i> in other tables.
part_name	user entered name for part (from create parts window)
part_number	user entered number for part
part_description	user entered description
date_entered	date and time the part was created by user
k_factor	k_factor calculated by routine or entered during part creation
k_offset	offset calculated or entered.

Columns of table parts

column name	description
ID	test ID number, ref'd by <i>fk_tests</i> in other tables.
test_name	user entered test name, from start test window
description	user entered test description
fk_parts_dut1, fk_parts_dut2, fk_parts_dut8	8 columns. Each "dut" column contains the part ID number, which references the part ID in the <i>parts</i> table. This "connects" the part names to the DUT channels.
fk_projects	which project this test is a member of. New projects are created in the main window with the edit/create project button.
starttime	time the cycling test started.
stoptime	time the cycling test ended. (not implemented yet.)

Columns of table tests

column name	description
ID	project ID number, ref'd by fk_projects in other tables
name	project name
The projects table may store more detailed information in the future.	

Columns of table projects

9.3 As-Shipped Database information.

If a user is fluent in SQL database queries, they may find it useful to directly pull data from the database. This can be a very fast way of determining the condition of parts currently under test, as well as sorting out and selecting subsets of data.

Wyeast Technology does not recommend changing table structure or adding data to the database independent of the normal host control software.

Host system accompanying 354A serial number _____

was shipped with host system passwords

system user cycler

MySQL root password

MySQL user *cycler*, password _____